

<b>Notice of References Cited</b>	Application/Control No. 10/771,527	Applicant(s)/Patent Under Reexamination HAGINO, HIROSHI	
	Examiner Patricia Leith	Art Unit 1655	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**NON-PATENT DOCUMENTS**

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